# **Photonics**

R. Baets - E. Bente

## **Semiconductor light sources – Part A**

Optical properties of semiconductors

#### **Photonics**

### Semiconductor materials in photonics

- Semiconductor materials form the basis for:
  - Light emitting diodes (LED)
  - Diode lasers
  - Optical detectors and Solar cells
- Semiconductor materials:
   devices for efficient conversion from electricity to light and vice versa.
- Semiconductor energy level structure:
   different from atoms, ions / molecules Discrete levels
  - → crystalline solid state: high number of discrete levels wide energy range
    - Difference in achieving population inversion pumping mechanism.



### **Content**

- (Part A) Semiconductor materials
  - Energy level structure
  - Electrons and hole distribution over the energy levels
  - Optical gain, loss, refractive index
- (Part B) Role of pn-junctions and heterojunctions
- (Part C) Semiconductor light sources: Light emitting diode
- (Part D) Semiconductor light sources: Laser diode

### Concepts semiconductor physics and devices

Assumption you know from: 5ECB0 Electronic circuits 1

#### Concepts assumed known:

- Electrons and holes
- Intrinsic and doped semiconductors
- Donor and acceptor concentration
- Electron and hole mobility
- Electron and hole diffusion

#### Concepts assumed to be new in this course:

- Bandgap
- Valence and conduction band
- Electron and hole recombination
- Electron and hole lifetime
- Direct and indirect bandgap
- Effective mass of electrons and holes
- Density of states
- Fermi level

#### In detail:

5XPB0 "Nanodevices and integration" B Q4 5CCA0 "Semiconductor physics and materials" M Q1

### **Semiconductors - chemical composition**

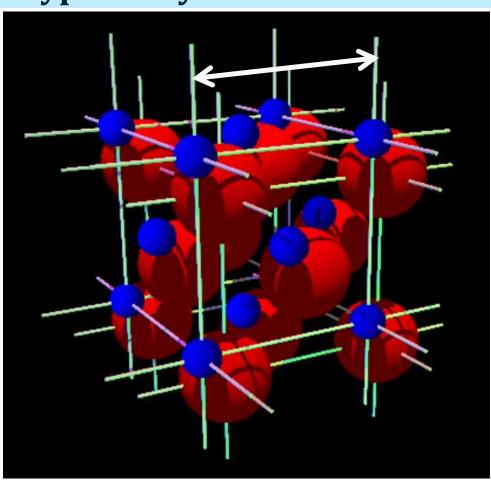
- Covalent bonds: fill the last shell  $\rightarrow$  8 electrons
- Group IV semiconductors: Si, Ge (4+4 e<sup>-</sup>)
- Binary semiconductors; two components
  - IV-IV: SiGe
  - III-V: GaAs, InP, GaN, InN (3+5 e<sup>-</sup>)
  - II-VI: CdTe, ZnSe,...  $(2+6 e^{-})$
- Ternary semiconductors
  - III-V:Al<sub>1-x</sub>Ga<sub>x</sub>As,
- Quaternary semiconductors

$$\blacksquare$$
 III-V:In<sub>1-x</sub>Ga<sub>x</sub>As<sub>1-y</sub>P<sub>y</sub>, ...

	IIIa	IVa	Va	VIa
	В	С	N	0
IIb	Al	Si	P	S
Zn	Ga	Ge	As	Se
Cd	In	Sn	Sb	Те

Section of periodic system of elements

### Typical crystal structure III-V semiconductors



The size of the unit cell of the crystal structure is characterized by a single number:

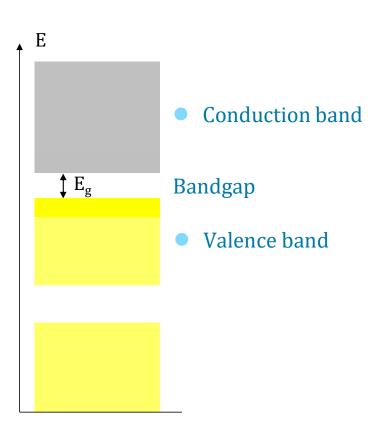
the lattice constant

 Given the crystal structure and the lattice constant one can calculate the position of each atom.



### **Energy band structure semiconductor**

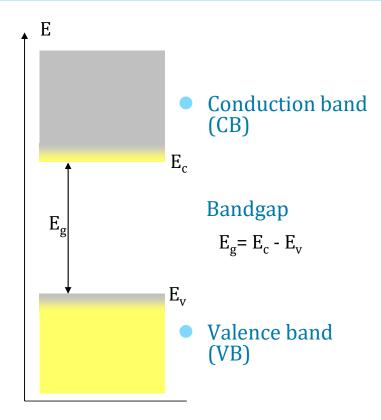
- The band diagram of the crystal: an isolator.
- Energy bands formed by a large number of discrete bound states for electrons in the material. (Quasi-continuum)
- Conduction band: no electrons at Temperature = 0 K
- The Valence band: states completely filled at T = 0 K



#### **Photonics**

### **Energy band structure semiconductor**

- In semiconductor: Bandgap E<sub>g</sub> relatively small: thermal energy excites a few electrons from Valence band to the Conduction band
- At T > 0 Electrons in conduction band:
   some conductivity (<u>highly temperature dependent</u>)
   -> semiconductor
- Electrons promoted to the conduction band:
   <u>open position</u> in the Valence band
   Provides conductivity:
  - Hole
  - = Quasi-particle positively charged



Only consider the top of VB and bottom of CB

### Carrier concentrations in intrinsic semiconductors

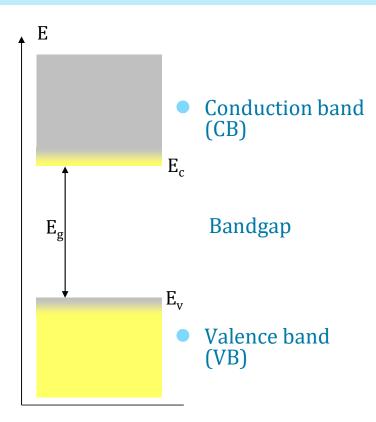
- Electrons and holes are named: charge carriers; or for short carriers
- Concentration electrons in conduction band:  $n_i$
- ullet Concentration holes in valence band:  $p_i$

Intrinsic = pure material

Electrons promoted to conduction band-> a hole in the valence band:

$$n_i = p_i \qquad n_i \cdot p_i = n_i^2$$

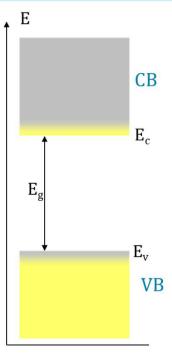
 The electrons and holes created by temperature will be neglected when <u>optical properties</u> of intrinsic materials are discussed



### Electrons: Effective mass, density of states conduction band

- Model: Electrons in CB and holes in VB **move** as free particles (compare with 3D cube quantum model)
- The difference with a free particle is the mass:
  - The electrons have an **effective mass**  $m_n^*$
  - The **effective mass** depends on the material e.g. in GaAs:  $m_n^* = 0.067 \times m_0$  (m<sub>0</sub> is rest mass electron)
- Lowest energy levels/states for electrons in CB
  - **Density** of states for electrons  $g_c(E)$  in CB (similar to 3D cube)

$$g_c(E) = \frac{4\pi (m_n^*)^{3/2}}{h^3} \sqrt{E - E_c} \quad E - E_c > 0$$



- # of states per unit volume in CB in a small energy interval at  $\Delta E$  energy  $E:~g_c(E)\cdot \Delta E$
- # of states per unit volume in CB between energy  $E_1$  and energy  $E_2$ :  $\int_{E}^{E_2} g_c(E) \cdot dE$ 10

### Holes: Effective mass, density of states valence band

- The holes in the valence band each have an **effective mass**  $m_p^*$
- Highest energy levels/states for holes in valence band
  - Density of states for holes in VB (similar to 3D cube)

$$g_v(E) = \frac{4\pi (m_p^*)^{3/2}}{h^3} \sqrt{E_v - E} \qquad E_v - E > 0$$

ullet # of states per unit volume in the VB in a small energy interval at  $\Delta E$  energy  $E:~g_{m v}(E) \cdot \Delta E$ 

• # of states per unit volume in the VB between energy  $E_1$  and energy  $E_2$ :  $\int_{E_1}^{E_2} g_v(E) \cdot dE$ 

### Electrons and holes: energy, momentum and wavelength

ullet electrons in CB moving through crystal as free particles with effective mass  $m_n^*$  :

Momentum: 
$$|\vec{p}| = m_n^* \cdot |\vec{v}| = \hbar \cdot k = \frac{h}{\lambda}$$

All energy over  $E_c$  is kinetic energy

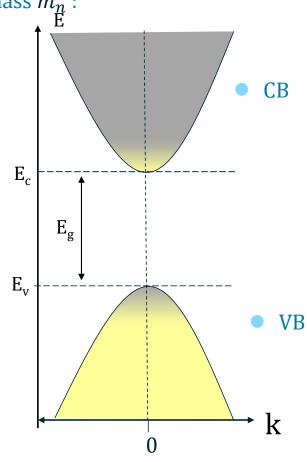
Energy: 
$$E - E_c = \frac{1}{2} m_n^* v^2 = \frac{p^2}{2 \cdot m_n^*} = \frac{\hbar^2 k^2}{2 \cdot m_n^*}$$

• holes in VB moving through crystal as free particles with effective mass  $m_p^*$ :

Momentum: 
$$|\vec{p}| = m_p^* \cdot |\vec{v}| = \hbar \cdot k = \frac{h}{\lambda}$$

All energy below  $E_c$  is kinetic energy

Energy: 
$$E_v - E = \frac{1}{2} m_p^* v^2 = \frac{p^2}{2 \cdot m_p^*} = \frac{\hbar^2 k^2}{2 \cdot m_p^*}$$



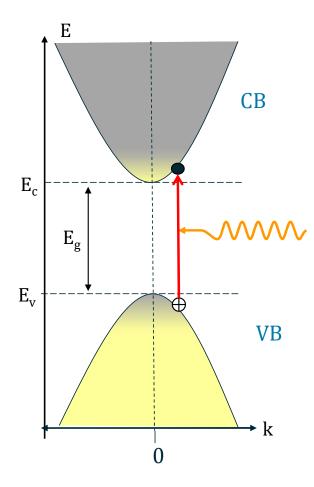
### Light absorption in semiconductors

- Photon energy << Bandgap: little absorption</p>
- Photon energy ~ Bandgap: large increase in absorption
  - Electrons from valence band are excited to conduction band

k-vector of the electron stays the same.

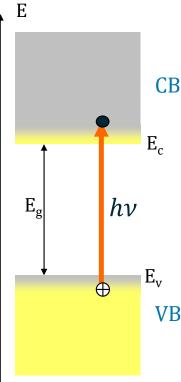
- Conservation of momentum
- Direct bandgap:

Minimum CB at same k value as maximum VB in E-k diagram



### Generation/recombination of excess carriers

- Carrier concentrations can be made much higher than thermal equilibrium values → excess carriers
- <u>Excess</u> electrons fill the states in the CB from the bottom of the CB
   <u>Excess</u> holes fill the states in the VB from the top of the VB
- Origin of excess carriers:
  - Injection of carriers (current, using diode structure)
  - Absorbing photons  $h \nu \ge E_g$
- Excess carrier concentrations (electrically neutral)  $\delta n = \delta p$
- No thermal equilibrium between CB and VB population however:
  - thermal equilibrium within CB and VB (quasi equilibrium)



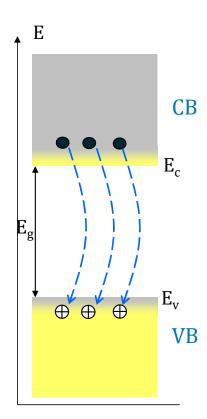


### **Excess electron-hole recombination**

Recombination:

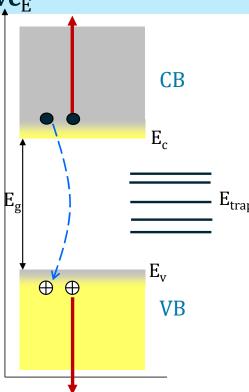
The non-equilibrium situation will relax to equilibrium.

- Recombination rate for excess electrons and holes is the same
- -> lifetime of excess electrons and holes is the same



Excess electron-hole recombination processes – non radiative

- Recombination electron and hole
  - Non-radiative processes
  - At crystal defects (contaminations, lattice defects, surfaces)
    - These create states in the bandgap (trap states)
  - Three carrier collisions
    - Energy transferred to a different electron or hole:
      Auger recombination
  - A phonon (lattice vibration): via defects or surface states
  - Total nonradiative recombination rate U<sub>nr</sub> # recombinations m<sup>-3</sup>s<sup>-1</sup>



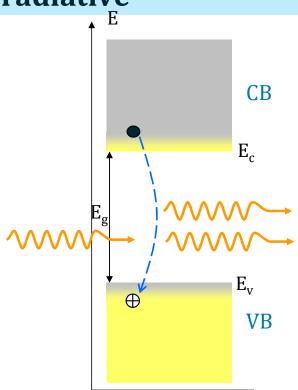
### Excess electron-hole recombination processes - radiative

- Energy released with spontaneous recombination event
  - As a photon:  $\rightarrow$  <u>radiative</u> recombination  $U_r$
- Radiative processes
- Spontaneous recombination and emission of photon
- <u>Stimulated recombination</u> and emission of a photon

k-vector of the electron and hole

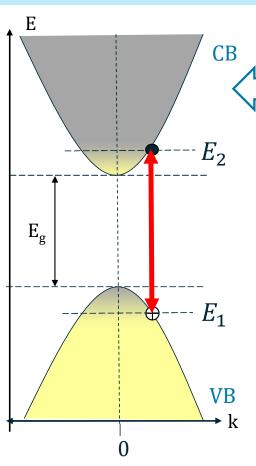
must be the same – direct band gap

- Total recombination rate  $U = U_r + U_{nr}$
- Lifetime of electron/hole: average time that a charge carrier stays in an excited state before recombining
  - Recombination process with shortest lifetime dominates



$$U \sim \frac{1}{\tau_{p,n}}$$

Direct and indirect bandgap - recombination of carriers

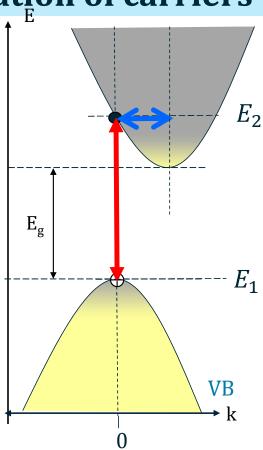


Direct bandgap transition

Radiative recombination usually dominates

Indirect bandgap transition

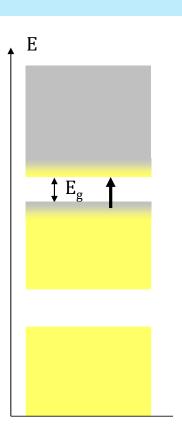
- Radiative recombination improbable: photon can not take mismatch in k (momentum)
- Difference in k-vector is compensated by phonon or third particle.
- Non-radiative processes dominate recombination in indirect bandgap semiconductors: e.g. Si



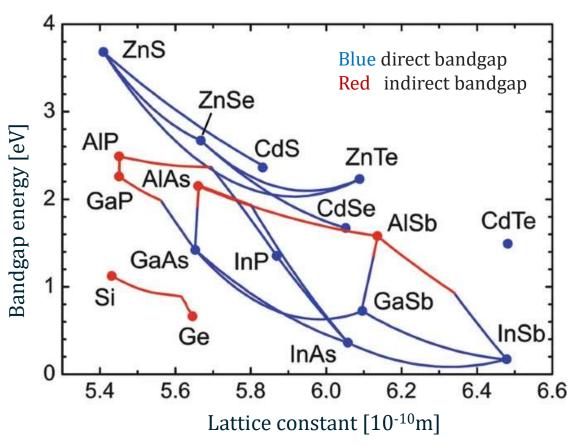


### Types of semiconductor

- Classification according to
  - Chemical composition
    - single element, binary, ternary, ... semiconductors
  - Band structure
    - Direct or indirect bandgap, size of bandgap
  - Doping
    - Intrinsic, p or n-type doping, control of conductivity by electrons or holes

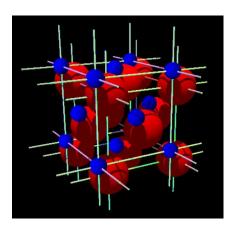


### Bandgap – lattice constant – semiconductors



Böer, K.W., Pohl, U.W. (2023). Bands and Bandgaps in Solids. In: Semiconductor Physics. Springer, Cham. https://doi.org/10.1007/978-3-031-18286-0\_8

Lattice constant: size of cube shaped unit cell in the crystal



Ternary material on lines between binary materials

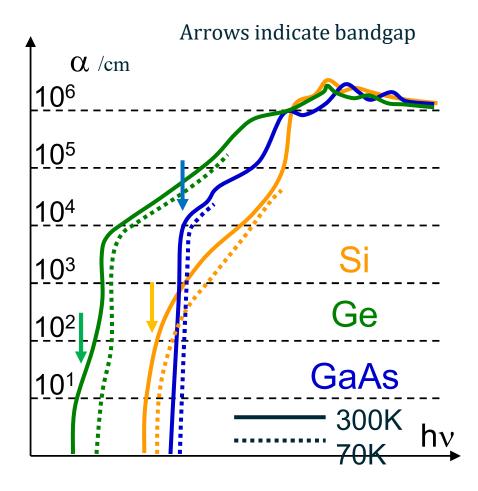
### Light absorption in semiconductors

Direct band structure: sudden increase of absorption

Indirect band structure: slow increase of absorption

Ge 0.66 eV => 1879 nm

Ge is close to direct bandgap



#### Intrinsic semiconductor – excess electrons in the CB

- We now know the where the energy levels are. Question: which levels in the CB will excess electrons occupy?
  - Thermal distribution within CB (quasi equilibrium)

Probability of finding an energy level occupied at energy E:

$$f_c(E) = \frac{1}{\exp\left(\frac{E - E_{Fn}}{k_B T}\right) + 1}$$
 (Fermi-Dirac distribution, eq.10.19)

 $E_{Fn}$  is the **quasi-Fermi** energy for the CB

Number of electrons in the CB per unit volume per unit energy:

$$N(E) = f_c(E) \cdot g_c(E)$$

Total number of electrons in the CB per unit volume in thermal equilibrium:

$$\delta \mathbf{n} = \int_{E_c}^{\infty} f_c(E) \cdot g_c(E) \cdot dE$$
Neglect intrinsic carrier concentration

### Intrinsic semiconductor - excess holes in the VB

- We now know the where the energy levels are.Question: which levels in the CB will excess electrons occupy?
  - Thermal distribution within CB (quasi equilibrium)

Probability of finding an energy level occupied at energy E:

$$f_{v}(E) = \frac{1}{\exp\left(\frac{E - E_{Fp}}{k_{B}T}\right) + 1}$$
 (Fermi-Dirac distribution, eq.10.19)  
$$E_{Fp} \text{ is the } \frac{\text{quasi-Fermi}}{\text{energy for the VB}}$$

• Number of holes in the VB per unit volume per unit energy:

$$P(E) = (1 - f_v(E)) \cdot g_v(E)$$

Total number of holes in the CB per unit volume in thermal equilibrium:

$$\delta p = \int_{-\infty}^{E_c} (1 - f_v) \cdot g_v(E) \cdot dE \qquad \text{Remember} \quad \underline{\delta p = \delta n}$$

This links the two quasi-Fermi energy values  $E_{Fp}$  and  $E_{Fn}$ .

### **Example 14.1 - Excess electrons in GaAs**

#### GaAs semiconductor material (intrinsic)

Bandgap: 
$$E_g = 1.42 \ eV = 2.275 \cdot 10^{-19} J$$

Bottom CB:  $E_c = 1.42 \ eV$ 

Top VB: 
$$E_v = 0.0 \ eV$$
  $T = 300 \ K$ 

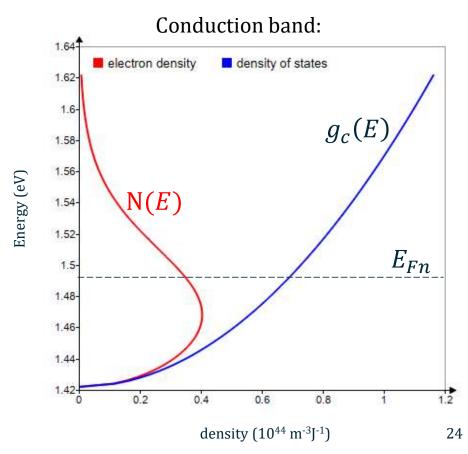
effective mass 
$$m_n^* = 0.067 \cdot m_0$$
  
effective mass  $m_p^* = 0.46 \cdot m_0$   
 $m_0 = 9.1 \cdot 10^{-31} kg$ 

#### Assume e.g.

$$E_{Fn} = 1.491 \ eV$$
  $\delta n = \int_{E_c}^{\infty} f_c(E) \cdot g_c(E) \cdot dE$ 

numerical calculation:  $\delta n = 6.16 \cdot 10^{23} \ m^{-3}$ 

#### concentration and quasi-Fermi level linked



### Example 14.1 GaAs excess holes

#### GaAs semiconductor material (intrinsic)

Bandgap: 
$$E_g = 1.42 \ eV = 2.275 \cdot 10^{-19} J$$

Bottom CB:  $E_c = 1.42 \ eV$ 

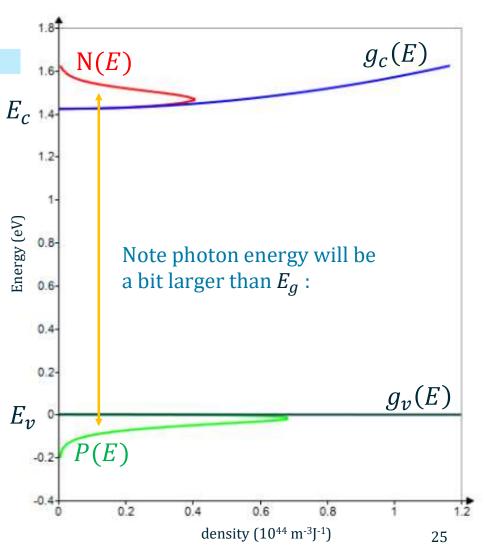
Top VB: 
$$E_v = 0.0 \ eV$$
  $T = 300 \ K$ 

effective mass  $m_n^* = 0.067 \cdot m_0$ effective mass  $m_p^* = 0.46 \cdot m_0$  $m_0 = 9.1 \cdot 10^{-31} kg$ 

$$\delta p = \delta n = \int_{-\infty}^{E_c} (1 - f_v(E)) \cdot g_v(E) \cdot dE$$

$$\delta p = \delta n = 6.16 \cdot 10^{23} \, m^{-3}$$

 $E_{Fp} = 0.037eV$  Just above  $E_v$  follows from:



### Example 14.1 - GaAs thermal equilibrium

GaAs semiconductor material (intrinsic)

Bandgap:

$$E_g = 1.42 \ eV = 2.275 \cdot 10^{-19} J$$

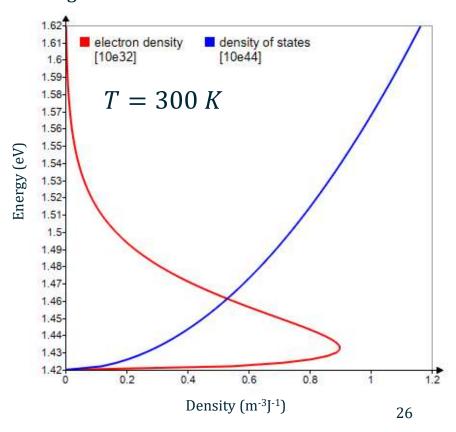
<u>In thermal equilibrium</u> (no excess carriers):

$$E_{fp} = E_{fn} \quad E_f = 0.74735 \text{ eV}$$

$$n_i = \int_{E_c}^{\infty} f_c(E) \cdot g_c(E) \cdot dE$$

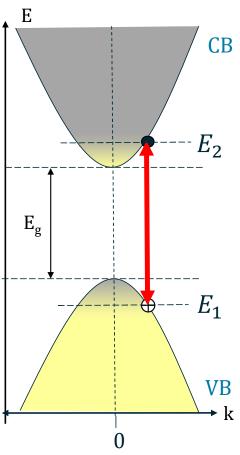
$$n_i = p_i = 7.7 \cdot 10^{11} \ m^{-3}$$

This is a small number compared to the total number of (outer) electrons per unit volume in the material.



### Condition for optical gain: Population-inversion

- To achieve population inversion in intrinsic material
  - Conduction band strongly filled = many free excess electrons
  - Valence band relatively empty = many free excess holes
- Pumping excess carriers in material:
  - Optically
  - Electrically: p-i-n double heterojunction: in forward bias current
- CB and VB out of thermal equilibrium
  - Quasi Fermi level  $E_{fn}$  for electrons in CB
  - Quasi Fermi level  $E_{fp}$  for holes in VB
- Question? what is the concentration of excess carriers needed to achieve inversion / optical gain for a transition between levels at  $E_1$  and  $E_2$  with the same k



### Probabilities finding excess electrons and holes

• Probability finding an electron at energy  $E_2$  in conduction band:

$$f_c(E_2) = \frac{1}{\exp\left(\frac{E_2 - E_{Fn}}{k_B T}\right) + 1}$$

• Probability of finding a hole at energy  $E_1$  in valence band: = probability of not finding an electron at  $E_1$ :

$$1 - f_v(E_1) = 1 - \frac{1}{\exp\left(\frac{E_1 - E_{Fp}}{k_B T}\right) + 1}$$

### Optical gain in a semiconductor- Absorption rate

Absorption rate:

$$R_{ab} = B_{12} \cdot f_v(E_1) \ g_v(E_1) \cdot \left(1 - f_c(E_2)\right) g_c(E_2) \cdot \rho_p(E_2 - E_1)$$

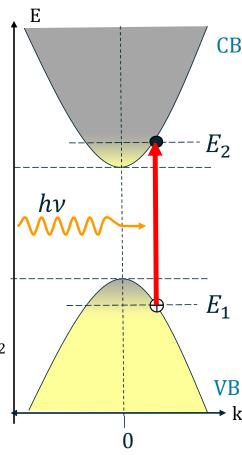
 $B_{12}$  Einstein coefficient - transition probability for absorption

 $f_c(E_2)$  Fermi distribution quasi Fermi level  $E_{Fn}$ 

 $f_v(E_1)$  Fermi distribution quasi Fermi level  $E_{Fp}$ 

 $g_v(E_1)$   $g_c(E_2)$  Density of states valence band at  $E_1$ , conduction band at  $E_2$ 

 $\rho_p(E_2-E_1)$  Density of photons with correct energy  $E_2$  -  $E_1$ 

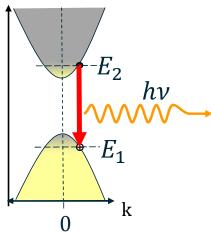


### **Spontaneous and stimulated emission rates**

#### Spontaneous emission rate

$$R_{sp} = A_{21} \cdot f_c(E_2) \ g_c(E_2) \cdot (1 - f_v(E_1)) \ g_v(E_1)$$

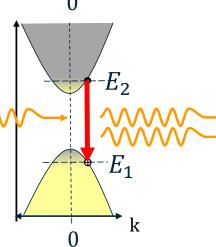
 $A_{21}$  Einstein coefficient - transition probability for spontaneous emission



#### Stimulated emission rate

$$R_{st} = B_{21} \cdot f_c(E_2) g_c(E_2) \cdot (1 - f_v(E_1)) g_v(E_1) \cdot \rho_p(E_2 - E_1)$$

 $B_{21}$  Einstein coefficient - transition probability for stimulated emission



### **Condition for optical gain**

Rate for stimulated emission > Rate for absorption  $R_{st} > R_{ab}$ 

$$B_{21} \cdot f_c(E_2) g_c(E_2) \cdot (1 - f_v(E_1)) g_v(E_1) \cdot \rho_p(E_2 - E_1) > B_{12} \cdot f_v(E_1) g_v(E_1) \cdot (1 - f_c(E_2)) g_c(E_2) \cdot \rho_p(E_2 - E_1)$$

$$f_c(E_2) \cdot (1 - f_v(E_1)) > f_v(E_1) \cdot (1 - f_c(E_2))$$

Substituting the Fermi functions leads to the condition:

$$E_{Fn} - E_{Fp} > (E_2 - E_1) \ge E_g$$

Net optical gain when: quasi-Fermi levels are separated by more than the band gap:

inversion condition for semiconductors

- Transparency if  $E_{Fn} E_{Fp} = E_g$  Gain if  $E_{Fn} E_{Fp} > E_g$ 
  - Excess electron and hole concentration:  $\delta n = \delta p = n = p \sim 2.10^{18}$  cm<sup>-3</sup>
- Photon energy from E<sub>G</sub> to a bit above

### Optical gain calculation - principle

Net rate of amplification is:  $R_{net} = R_{st} - R_{ab}$ 

$$R_{net} = B_{21} \cdot g_c(E_2) g_v(E_1) \cdot (f_c(E_2) - f_v(E_1)) \cdot \rho_p(E_2 - E_1)$$

The density of states for the carriers.

Determined by material and its structure

The density of photons.

In a laser:

Determined by the

laser cavity

Structuring at the level of the electron wavelength influences the density of states

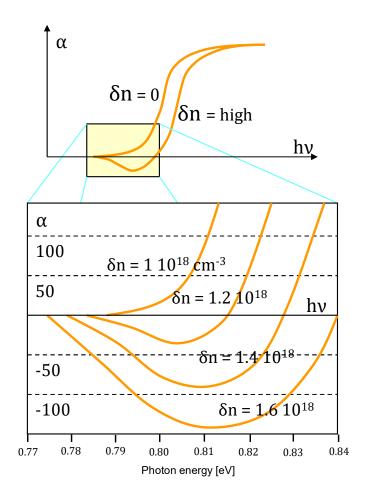
Structuring at the level of a fraction of the scale of the wavelength of light

The optical gain: 
$$g_{mat} = \frac{B_{21}}{v_g} g_c(E_2) g_v(E_1) \cdot \left(f_c(E_2) - f_v(E_1)\right)$$

 $v_g$  is the group velocity of the light

#### Stimulated emission in semiconductors

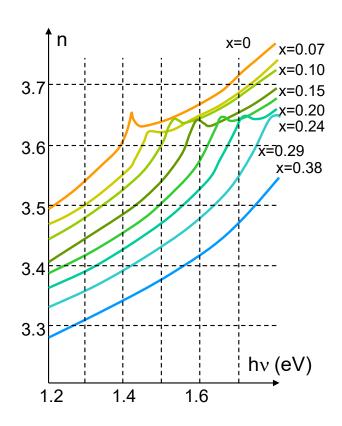
- Population inversion
  - Many excess holes in valence band
  - Many excess electrons in conduction band
  - No thermal equilibrium  $\delta n = \delta p$
- Stimulated emission > absorption
  - Occurs when  $\hbar\omega > E_G$
- Gain (for real amplifier InGaAsP structure)
  - Order of magnitude: 100 cm<sup>-1</sup>
  - Much smaller than  $\alpha$  for large photon energy





### Refractive index of semiconductors

- High refractive index
  - n = 3.0 4.0
  - Large bandgap => low n
  - n = wavelength dependent (dispersion)
  - Increases with photon energy
- Refractive index peak at bandgap
  - Change in absorption also changes the refractive index (K-K)
- Example. Al<sub>x</sub>Ga<sub>1-x</sub>As
  - n decreases for increasing x





### Influences on optical properties of semiconductors

- Refractive index n can be influenced by
  - Temperature (thermo-optic effect)
  - Electron and hole concentration (the gain and absorption curve, plasma effect,...)
  - Static electric field (Pockels effect, Kerr effect, Stark effect)
  - $\blacksquare$  mechanical deformation  $\rightarrow$  stress
- The bandgap also depends on these parameters: influence on absorption and hence refractive index
- Anisotropy of crystal structure
  - Properties depend on polarization and direction of light

# **Photonics**

R. Baets - E. Bente

### **Semiconductor light sources – Part B**

PN-junctions Light emission from pn-junctions



#### Content

- How to achieve high excess carrier concentrations?
  - pn-junction and heterojunctions (also useful for detectors)
- Semiconductor material systems

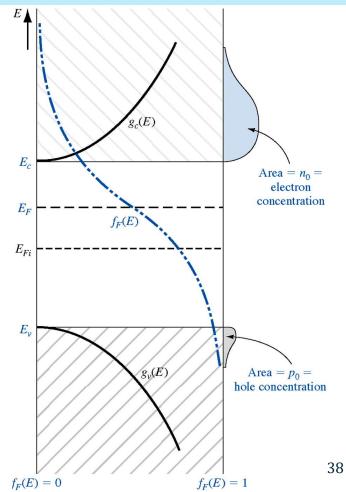
# Doped semiconductors - n doping - in equilibrium

- Add low concentration of atoms with a weakly bound outer electron.
- Thermal equilibrium
  - electron concentration in CB up
  - Hole concentration in VB down
- Fermi-level goes up!
- Doping concentration higher than intrinsic material
  - conductivity up

$$n_0 > p_0$$

$$n_0 > p_0 \qquad n_0 \cdot p_0 = n_i^2$$

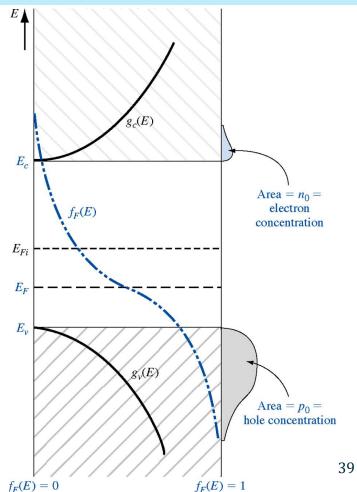
 $n_i$  is the carrier concentration in intrinsic (undoped material)



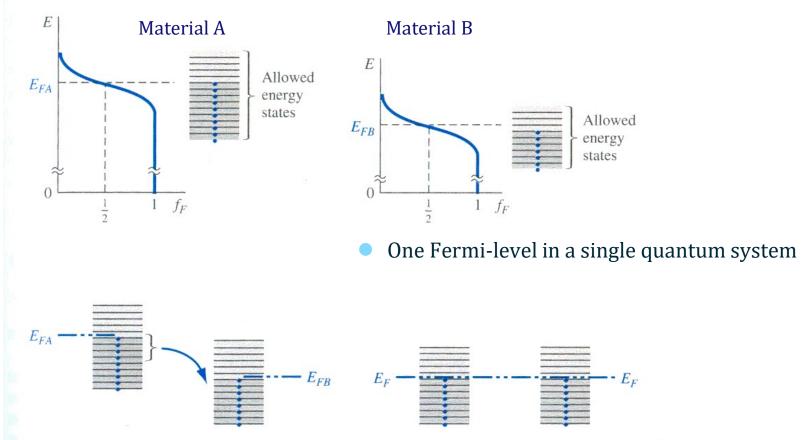
# Doped semiconductors - p doping - in equilibrium

- Add low concentration of atoms that can bind a free electron.
- Thermal equilibrium
  - electron concentration in CB down
  - Hole concentration in VB up
- Fermi-level goes down!
- Doping concentration higher than intrinsic material
  - conductivity up

$$n_0 < p_0 \qquad n_0 \cdot p_0 = n_i^2$$



# Relevance of the Fermi-energy level



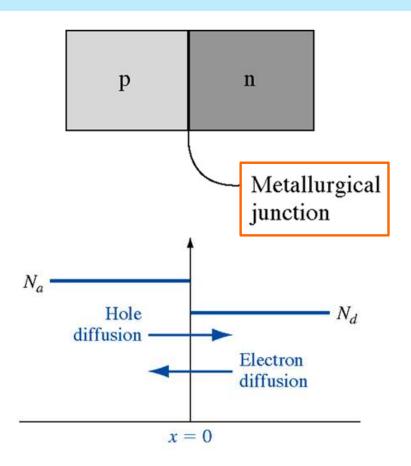
In thermal equilibrium the Fermi-energy is a constant in the system!



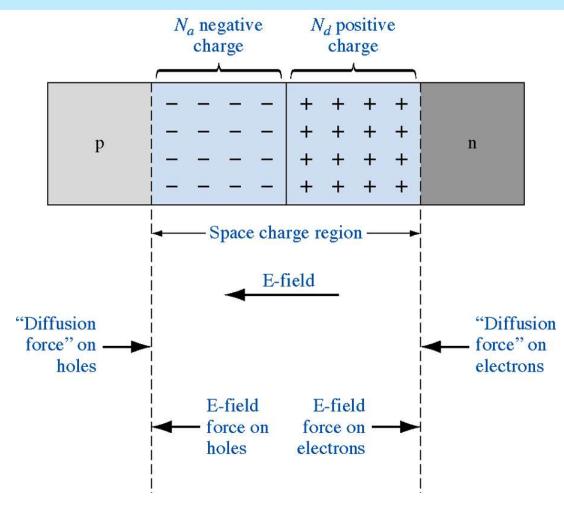
# The pn-junction

- p-type semiconductor: high concentration of holes p
- n-type semiconductor:high concentration of electrons n
- typical doping density :  $10^{17}/\text{cm}^3 10^{19}/\text{cm}^3$

 $N_a$  acceptor doping concentration  $N_d$  donor doping concentration

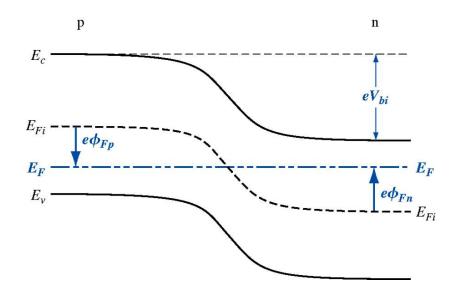


#### Balance between diffusion forces and electric field



#### Built-in potential barrier of the pn-junction

No applied voltage – thermal equilibrium => Fermi-level is constant



$$V_{bi} = |\phi_{Fn}| + |\phi_{Fn}|$$

$$V_{bi} = \frac{kT}{e} ln \left( \frac{N_a N_d}{n_i^2} \right)$$

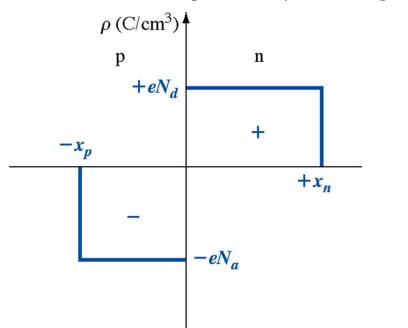
 $n_i$  is the carrier concentration in intrinsic (undoped material)

 $N_a$  is the p doping concentration

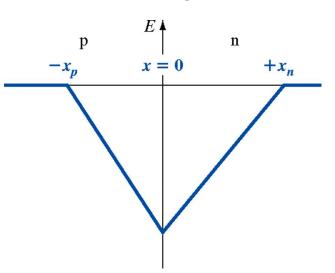
 $N_d$  is the n-doping concentration

### Charge distribution and electric field in the depletion region

• Relation between potential  $\phi(x)$ , charge density  $\rho(x)$  and electric field E(x):



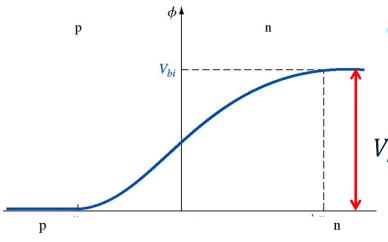
$$\frac{d^2\phi(x)}{dx^2} = -\frac{\rho(x)}{\epsilon_S} = -\frac{dE(x)}{dx}$$



The amount of charge at both sides of the junction is equal:

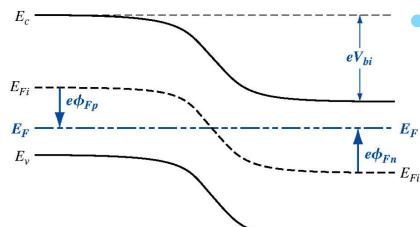
$$N_d x_n = N_a x_p$$

# Potential in the pn-junction



The electrical potential  $\varphi$  across the junction (proportional to energy of positive unit charge)

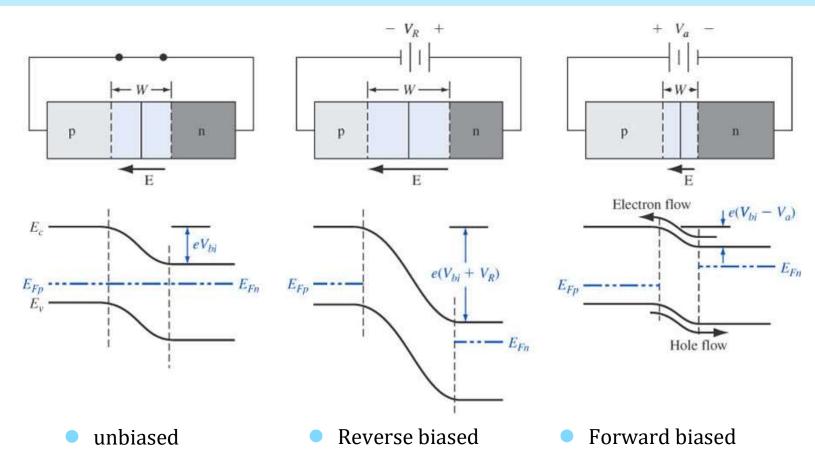
$$V_{bi} = |\phi(x = x_n)| = \frac{2}{2\varepsilon_S} \left( N_d x_n^2 + N_a x_p^2 \right)$$



The energy of electrons across the junction (energy of negative unit charge) in the CB and VB

band bending

# pn-junction - Reverse and Forward bias

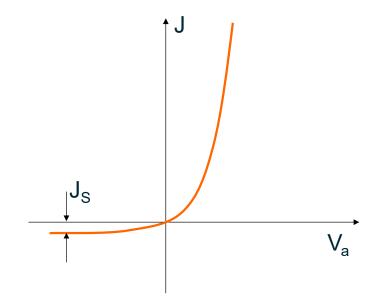


# I-V characteristic of a pn-junction

Shockley-equation

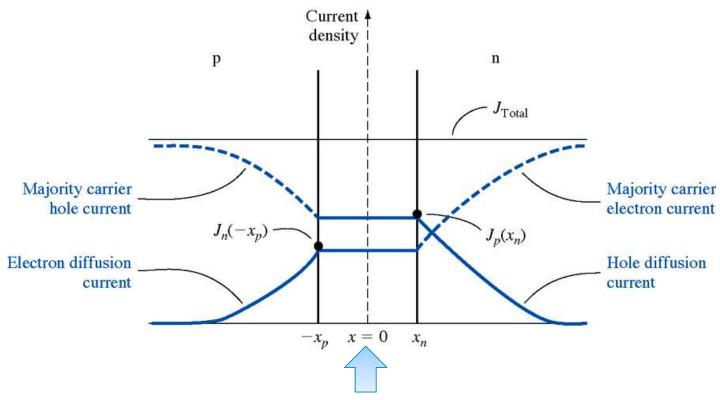
$$J = J_S \left[ exp \left( \frac{eV_a}{k_B T} \right) - 1 \right]$$

$$J_S = e \left( \frac{D_n n_{p0}}{L_n} + \frac{D_p p_{n0}}{L_p} \right)$$



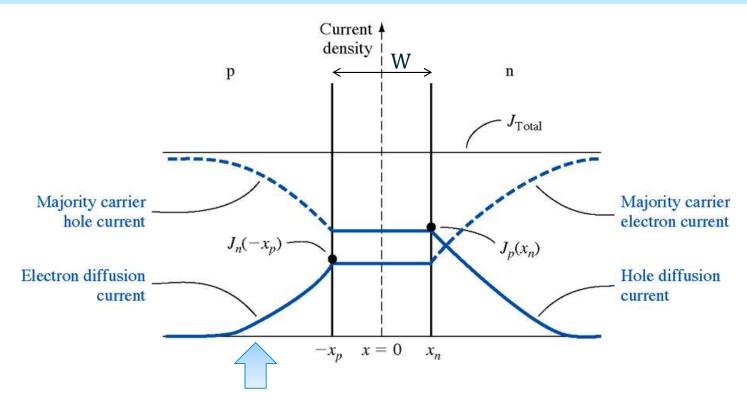
- $J_S$  is the ideal saturation current density
- D<sub>n</sub>, D<sub>p</sub> electron, hole diffusion coefficient
- L<sub>n</sub>, L<sub>p</sub> electron, hole diffusion length
- n<sub>p0</sub> thermal equilibrium electron concentration in p doped region
- $\bullet$   $p_{n0}$  thermal equilibrium hole concentration in n doped region

### Current density in pn-junction under forward bias



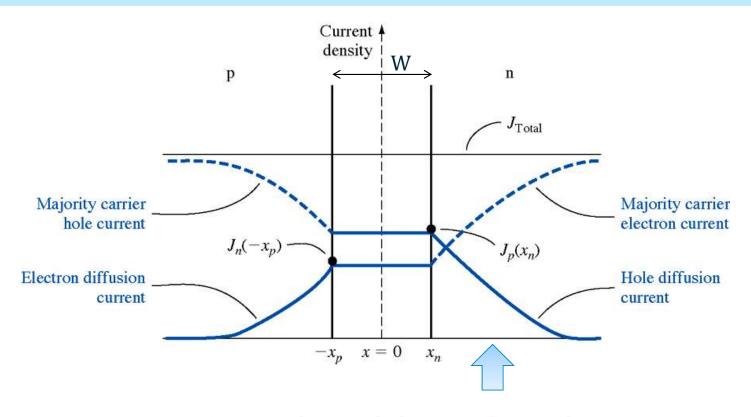
• Depletion layer  $(-x_p \text{ to } x_n)$ : carriers move fast due to strong electric field constant current density + high speed -> low carrier density

### Current density in pn-junction under forward bias



• p-region (x < -x<sub>p</sub>): injected excess electrons recombine with majority holes over region of length  $\sim$ L<sub>n</sub>  $\gg$  W

### Current density in pn-junction under forward bias



• n-region (x < -x<sub>p</sub>): injected excess holes recombine with majority electrons over region of length  $\sim$ L<sub>p</sub>  $\gg$  W



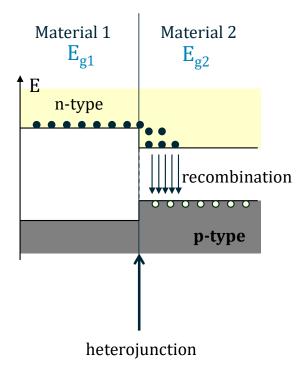
# Light emission and gain in pn-junction?

- Excess electron-hole recombination mainly in p or n region
  - Doping (p and n) increases absorption significantly!
  - The free carriers can absorb light
  - ideally: Recombination in undoped (intrinsic) material
- Recombination spreads out over diffusion length
  - difficult to achieve sufficient concentration of excess carriers to achieve transparency and gain
- Solution: use the double heterostructure



# Heterojunction – single

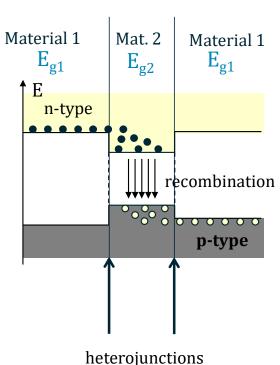
- Heterojunction: two different materials => different bandgap  $E_{g1} > E_{g2}$ 
  - Current carried by electrons on n-side
     by holes on the p-side
     holes are stopped at pn-junction by potential barrier
     electrons are injected into the p region
  - Recombination on the side with the smallest bandgap
  - Light not absorbed on n-side
  - Light generated in doped material (absorption) over diffusion length



#### **Photonics**

# Double heterojunction - carrier confinement

- Heterojunction: two different materials => different bandgap  $E_{g1} > E_{g2}$
- Double heterojunction pin-structure:
  - middle layer has smallest bandgap
  - middle layer is undoped intrinsic materialthin (e.g. 100nm)
  - Holes injected into middle layer from p-doped layer
  - Electrons injected into middle layer from n-doped layerhigh concentration of excess carriers
  - Electrons and holes captured in potential well in Material 2
  - Recombination, light generation in thin middle layer that is undoped (intrinsic)
  - Doped layers are transparent to light generated in middle layer.

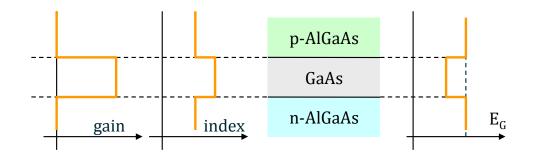


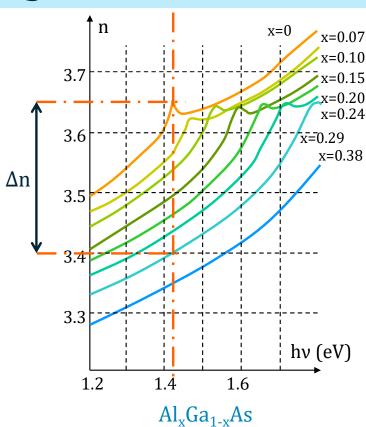


# Double heterostructure - waveguiding

- Heterojunction: two different materials => different bandgap  $E_{\rm g1}$  >  $E_{\rm g2}$
- Material with higher band gap -> lower refractive index -> Heterojunction structure forms <u>a waveguide</u>!

Example GaAs – 
$$Al_xGa_{1-x}As$$
  
 $E_g$  GaAs = 1.424 eV =>  $\lambda$  = 871 nm



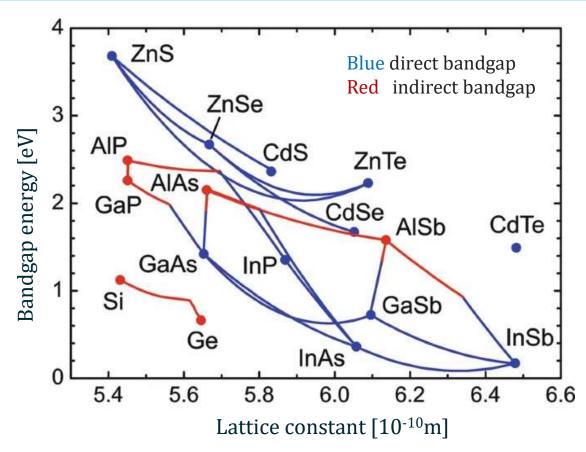


# Semiconductor materials for heterojunctions

Materials with different bandgap stacked

->
same lattice constant
required for growth of
single crystalline
materials

Materials growth is started from primary or binary semiconductors

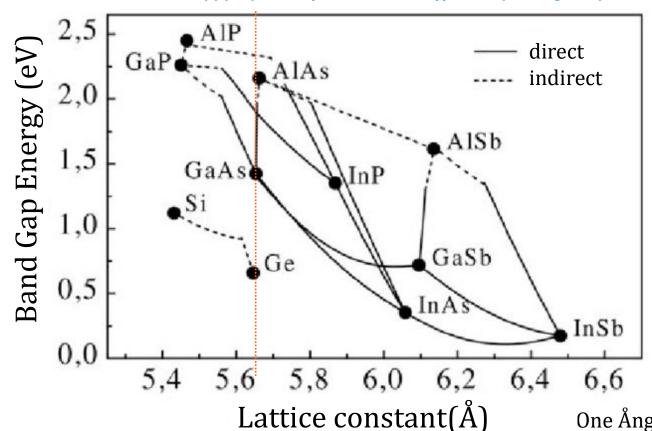


Böer, K.W., Pohl, U.W. (2023). Bands and Bandgaps in Solids. In: Semiconductor Physics. Springer, Cham. https://doi.org/10.1007/978-3-031-18286-0\_8



#### GaAs-AlGaAs

(5) (PDF) III-V compounds for solar cell applications (researchgate.net)

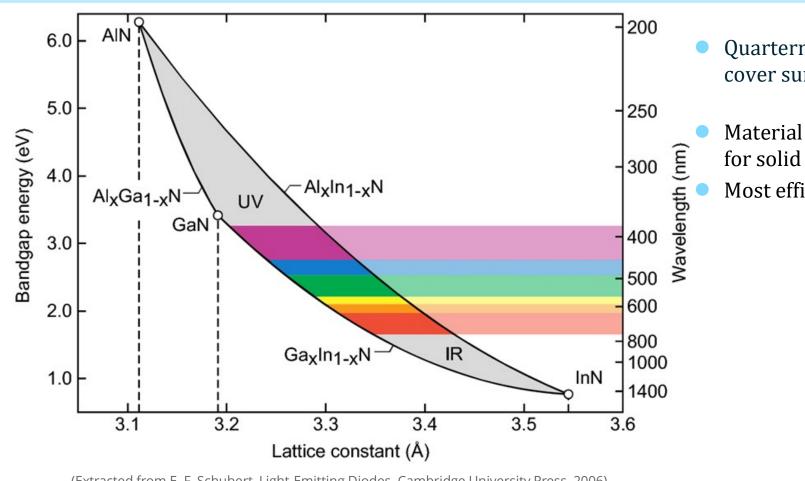


- Lattice constant GaAs AlGaAs only 0.12% difference
- Material  $Al_xGa_{1-x}As$  has direct bandgap for 0 < x < 0.45
- Important for 870 720nm
   e.g. pump diodes at 808 nm

One Ångstrom (Å) =  $10^{-10}$  meter



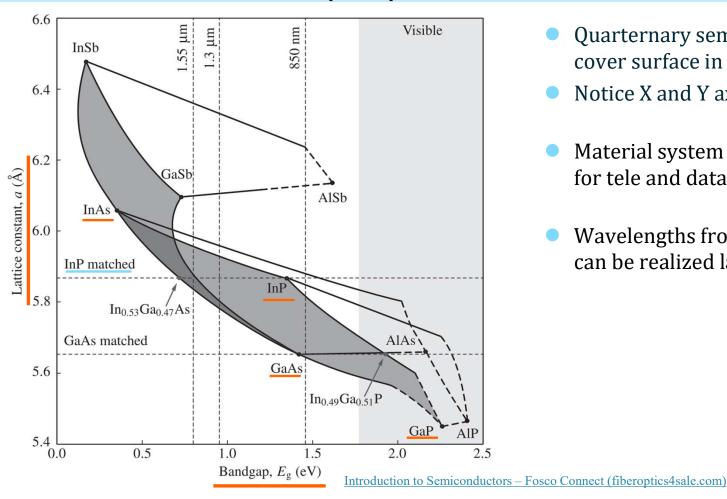
#### GaN-AIN-InN



- Quarternary semiconductors cover surface in diagram
- Material system GaN Ga<sub>x</sub>In<sub>1-x</sub>N for solid state lighting
- Most efficient for 400-390 nm

(Extracted from E. F. Schubert, Light-Emitting Diodes. Cambridge University Press, 2006).

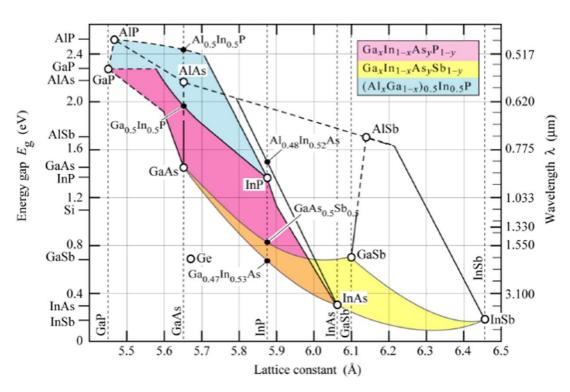
# $InP - In_{1-x}Ga_xAs_{1-y}P_{1-y}$



- Quarternary semiconductors cover surface in diagram
- Notice X and Y axis exchanged
- Material system InP  $In_{1-x}Ga_xAs_{1-y}P_{1-y}$ for tele and data communication
- Wavelengths from 1200 1640 nm can be realized lattice matched to InP



# $GaSb - Ga_xIn_{1-x}As_ySb_{1-y}$



Origin: Chegg.com

- Quarternary semiconductors cover surface in diagram
- System GaSb Ga<sub>x</sub>In<sub>1-x</sub>As<sub>y</sub>Sb<sub>1-y</sub> for gas detection – remote sensing
- Wavelengths from 2000 3000 nm can be realized lattice matched to GaSb
  - Sb = Antimony



## Next: semiconductor-based devices

# **Photonics**

R. Baets - E. Bente

# **Semiconductor light sources - Part C**

LED's

#### **Photonics**

# Semiconductor light sources

- LEDs
  - Lighting
  - Displays
  - Short range communication (fibre free space (LiFi)
- Laser diodes
  - Pump laser (e.g. for TiSa laser, fibre laser)
  - BluRay-player, PC-mouse, supermarket checkout
  - Optical communications fibre free space
  - LIDAR
  - Medical applications
  - Lighting
  - Manufacturing (e.g. soldering)



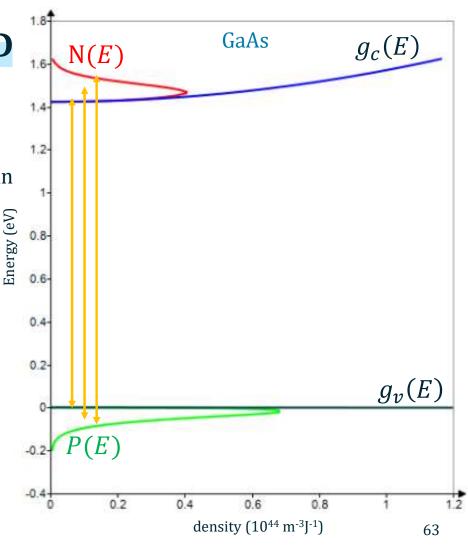




#### Radiative recombination in LED

- light emission: photon energy ~ just over bandgapcolor depends on material composition
  - => spontaneous emission spectrally wide, determined by distribution of carriers over the ban
- Internal efficiency  $\eta_i$ 
  - Fraction of electron hole pairs that recombine to produce a photon – material crystal quality
  - Can be close to 100% for infrared LEDs
  - Efficiency cab decrease at shorter wavelengths (green, blue)
     GaN blue LED can achieve 90%

 $GaAs_{1-x}P_x$  → IR, red to green Nitrides → green to blue, UV

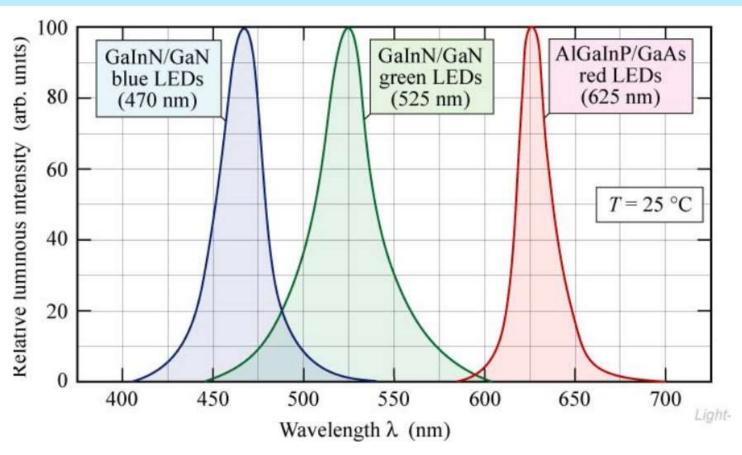




### **LED-materials**

λ (nm)	Color	Material	Application
1000-1600	IR	$In_xGa_{1-x}As_yP_{1-y}$	fiber communication
850-900	IR	GaAs	remote control
650	red	GaAs <sub>60</sub> P <sub>40</sub> , InGaP	displays
620	orange	GaAs <sub>35</sub> P <sub>65</sub> :N, InAlGaP	displays
590	yellow	GaAs <sub>15</sub> P <sub>85</sub> :N	displays
570	green	GaP:N	displays
280-500	Blue/UV	InGaN	lighting – displays

# Typical LED output spectra



After Toyoda Gosei Corp., 2000 (rpi.edu)

# Internal quantum efficiency

• Definition  $\eta_i$ : the number of emitted photons per e-h pair  $U_r$  e-h recombination rate per unit volume for radiative recombination U total e-h recombination rate per unit volume

• Photon flux  $\Phi_i$  generated in volume V in which e-h recombine

$$\Phi_i = U_r V$$
  $\longrightarrow$   $\Phi_i = \eta_i GV$ 

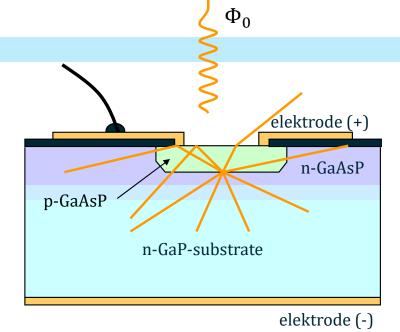
- G: electron-hole generation per time- and volume unit F Current injection I:  $G = I/(e \cdot V)$
- lacksquare steady state situation: total recombination rate  $\,=\,$  injection rate  $\,G\,=\,U\,$

**Photonics** 

Semiconductor light sources

### Extraction efficiency (1)

- Extraction efficiency  $\eta_e$ 
  - emission to substrate
  - total internal reflection
  - reflection on top-electrode
  - mostly < 1%
- Lambertian emitter:
  - isotropic radiation in LED
  - strong refraction on a flat surface



External quantum-efficiency  $\eta_{ex}$  = ratio between number of photons leaving the LED and number of injected electrons

$$\eta_{ex} = \eta_e \eta_i$$

$$\Phi_0 = \eta_e \Phi_i = \eta_e \eta_i \frac{I}{e} = \eta_{ex} \frac{I}{e}$$

with I the current through the pn junction  $\Phi_0\,$  the number of photons per second emitted



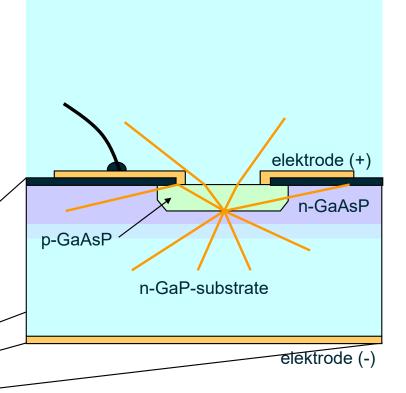
# Extraction efficiency (2)

 Improving extraction: integrate LED in transparent polymer material with high refractive index and curved surface

less TIR

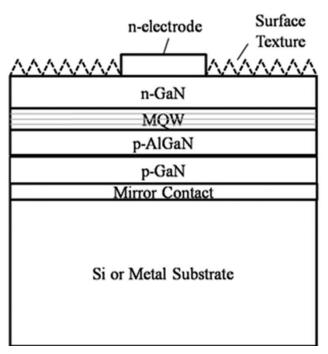
Works as collimating lens

Often used in display LEDs





#### Thin GaN LED structure

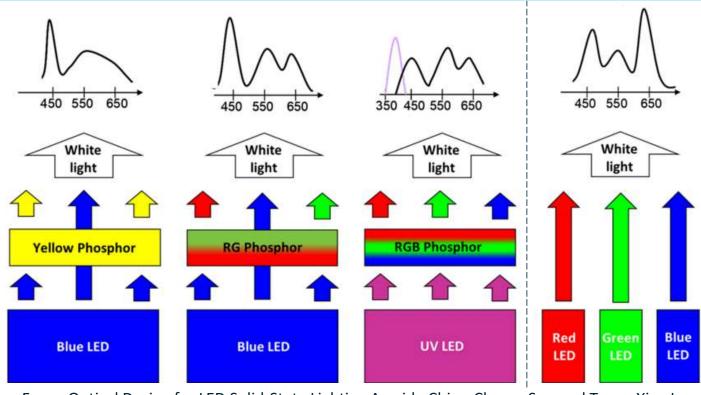


From: Optical Design for LED Solid-State Lighting A guide Ching-Cherng Sun and Tsung-Xian Lee

- Substrate can be sapphire (Al<sub>2</sub>O<sub>3</sub>), SiC
   Special techniques are applied to deal with lattice mismatch (16% for Al<sub>2</sub>O<sub>3</sub>).
- LED can be bonded to silicon or metal substrate for good thermal and electrical conductivity
- Surface texture to reduce TIR effects
- Fluorescent phosphor can be applied to top change colour of light

#### **Photonics**

# Ways to generate white light

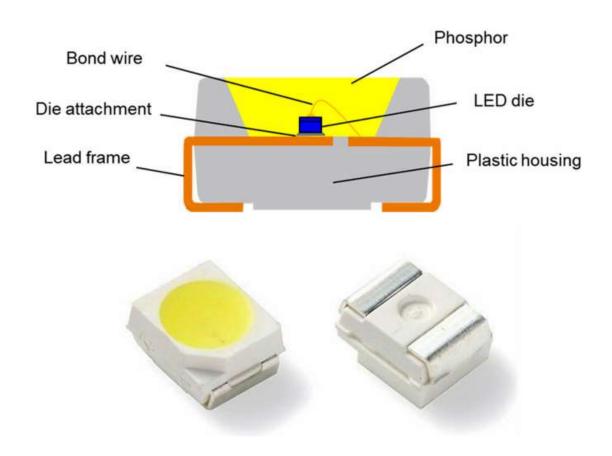


From: Optical Design for LED Solid-State Lighting A guide Ching-Cherng Sun and Tsung-Xian Lee

 Phosphor on top of LED – inorganic photoluminescent material (fluorescence – excitation blue / UV - emission longer wavelengths)



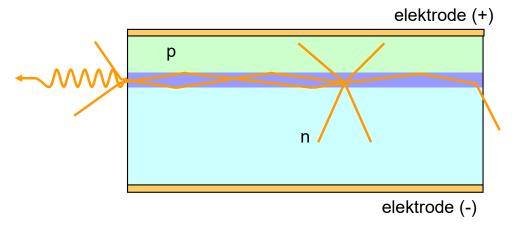
# Mid-power SMD LED





# Sideways emitting LED

- LED in waveguide structure: part of the light is guided by waveguide
- Light has a long path though active, light generating material must be above transparency
- There can be no cavity (as with laser diodes): mirror effect of facets needs to be suppressed
- Much larger radiance:
  - Same extraction efficiency
  - Small radiating surface
- Superluminescent operation high current
  - =>Stimulated emission is important
  - => Amplification of spontaneously emitted light
  - narrower spectrum
  - higher efficiency



#### LED Modulation bandwidth

Transfer of current variation to light variation (Response)

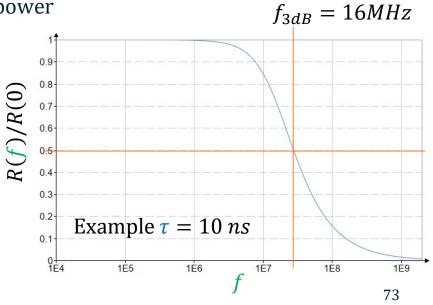
$$R(f) = \frac{\Delta P}{\Delta I} = \frac{R(0)}{\sqrt{1 + 4\pi^2 f^2 \tau^2}}$$

with  $\Delta I$  the modulation amplitude of the electrical current (sinusoidal at frequency f) and  $\Delta P$  the amplitude of the modulation of the optical power  $f_2$ 

electrical 3 dB bandwidth

$$R(f_{3dB}) = \sqrt{0.5}$$
  $f_{3dB} = \frac{1}{2\pi\tau}$ 

- with  $\tau$  the lifetime of the carriers: In semiconductors:  $\tau \sim \text{ns} => f_{3dB} = 50 - 100 \text{ MHz}$
- In practice often the capacity of the LED also limits the bandwidth





#### LEDs vs. laserdiodes

- LEDs
  - Low radiance
  - Low modulation bandwidth
  - Broad spectrum (sometimes that is good)
  - + cheaper
  - + reliable (up to 100,000h lifetime)
  - + efficiency and size compared to other lighting technology
  - + good in applications where low time coherence is important (no speckle)



#### **Excercise: LED**

- consider a double hetero junction LED n-InP/InGaAs/p-InP with the following properties:
- bandgap InP: 1.3 eV InGaAs: 0.8 eV
- radiative carrier lifetime  $\tau$ =1.20 ns
- Area 1x1mm²
- Recombination takes place in the 100nm thick InGaAs layer
- extraction efficiency  $\eta_e = 0.05$ , internal efficiency  $\eta_i = 0.25$
- What is the emission wavelength  $\lambda_0$  (vacuum wavelength)?
- What is the 3db bandwidth f<sub>3db</sub>?
- What is the radiant excitance Me of the LED at 100mA current?

# **Photonics**

R. Baets - E. Bente

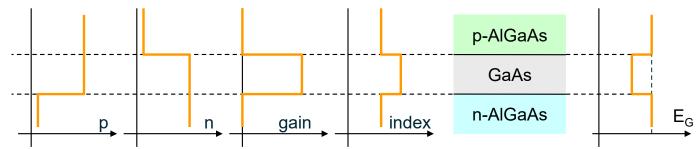
## **Semiconductor light sources - Part D**

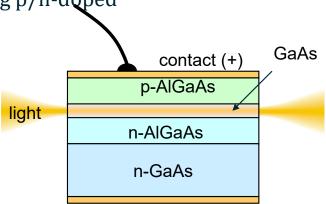
Laser diodes

# Double heterojunction-laser - example GaAs-AlGaAs

• Thin active GaAs layer  $(0.2 \mu m)$  intrinsic material; cladding p/n-doped

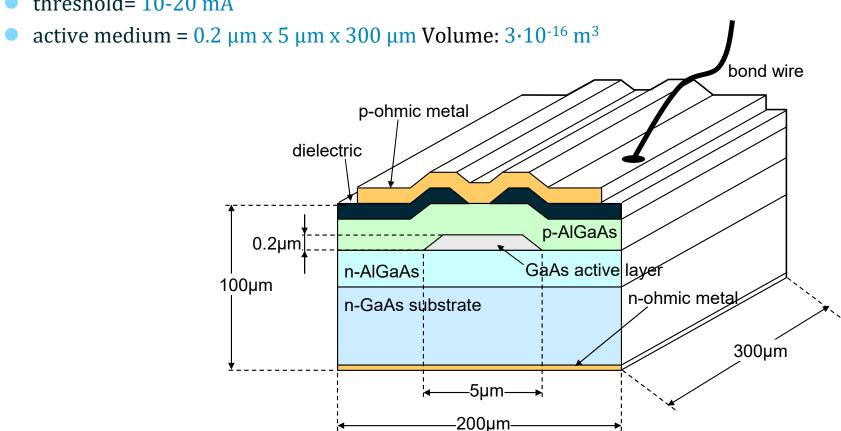
- Active layer:
  - higher refractive index → optical confinement
  - lower  $E_{gap} \rightarrow charge confinement$
  - high population inversion at optical mode position
- Resonator
  - Cleaved facets at ends act as mirrors
  - Light in waveguide
- → Typical current density for transparency (500 A/cm²)



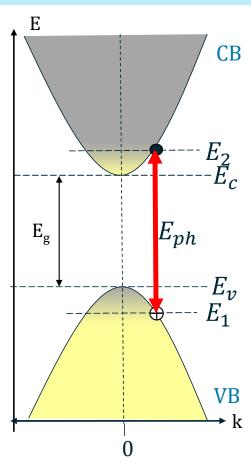


# Double heterojunction-laser - example GaAs-AlGaAs

threshold= 10-20 mA



# Example - current for transparency in GaAs laser (1)



Estimate current: GaAs transparent for light at  $\lambda = 835 \ nm$ . GaAs semiconductor material (intrinsic)

Bandgap:  $E_g = 1.42 \ eV \rightarrow \lambda_g = 873 \ nm$ 

Bottom CB:  $E_c = 1.42 \ eV$ 

Top VB:  $E_{v} = 0.0 \ eV$   $T = 300 \ K$ 

Condition gain:  $E_{Fn} - E_{Fp} \ge E_{ph}$ 

Transparency at:  $E_{Fn} - E_{Fp} = E_{ph} = E_2 - E_1$ 

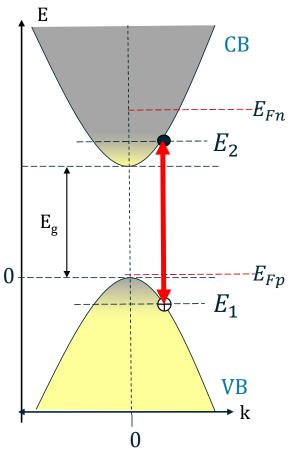
Calculate (excess) carrier concentration for transparency: Find  $E_{Fn}$  and  $E_{Fp} = E_{Fn} - E_{ph}$  such that:

$$\delta n = \int_{E_c}^{\infty} f_c(E) \cdot g_c(E) \cdot dE = \delta p = \int_{-\infty}^{E_c} (1 - f_v(E)) \cdot g_v(E) \cdot dE$$

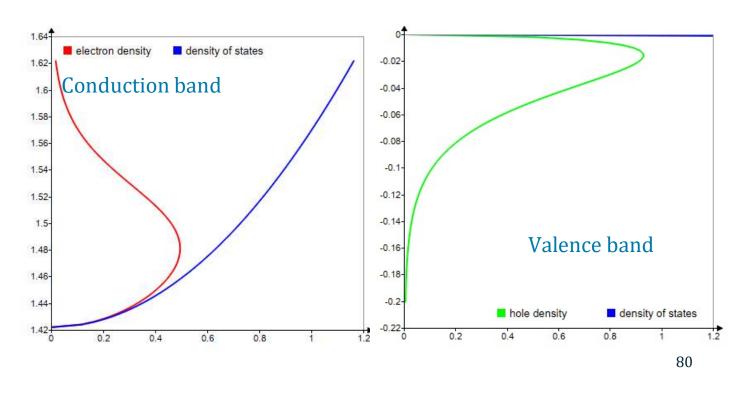
Calculation numerical for exact solution
Using approximations analytical solution possible.

# Example - current for transparency in GaAs laser (2)

Solution for is  $E_{Fn} = E_g + 0.09236 \ eV = 1.51236 \ eV \Rightarrow E_{Fp} = E_{Fn} - E_{ph} = 0.02752 \ eV$ 



$$\delta p = \delta n = 8.53 \cdot 10^{23} \, m^{-3}$$



## Example - current for transparency in GaAs laser (3)

Excess carrier concentration in GaAs semiconductor material  $\delta p = \delta n = 8.53 \cdot 10^{23} \ m^{-3}$  (intrinsic) needed for transparency:

If carrier lifetime is :  $\tau = 5 \cdot 10^{-9}$ s (usually this is not known accurately)

In steady state:  $\frac{\delta n}{\tau} = 1.71 \cdot 10^{32} \ m^{-3} s^{-1}$  Injected carriers needed to reach  $\delta p = \delta n$ 

Injected current:  $I_T = \frac{\delta n}{\tau} \cdot Volume \cdot e = 8.2 \, mA$  Volume= 0.2 µm x 5 µm x 300 µm = 3·10<sup>-16</sup> m<sup>3</sup>

Current density needed for transparency:

$$J_T = \frac{I_T}{l_{GaAs} \cdot w_{GaAs}} \cdot Volume \cdot e = 547 \frac{A}{cm^2}$$

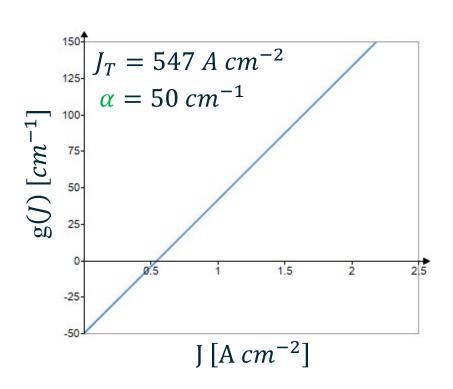


#### **Amplification**

• Simple phenomenological expression for amplification g(J) at peak gain wavelength  $\lambda_p$  as a function of electrical injection current density

$$g(J) = \alpha \left( \frac{J}{J_T} - 1 \right)$$

- I = I J = injected current density
- $I_T = I_T = I_T$
- $\alpha$  = absorption without injection



### Lasing condition

- Mirrors: facets cleaved along crystal planes
- Reflectivity value  $R = \left(\frac{n-1}{n+1}\right)^2$  e.g. GaAs (n=3.6) => R=0.32
- Gain compensates resonator losses
  - Light scattering loss in the amplifier:  $\alpha_s$  loss per unit length
  - Transmission of the cleaved facets (mirror reflectivities  $R_1$ ,  $R_2$ )
- Threshold condition gain:  $g_{th} = \frac{1}{2L} \ln \left( \frac{1}{R_1 R_2} \right) + \alpha_S$  See exercise laser Ch13

define 
$$\alpha_m \equiv \frac{1}{2L} \ln \left( \frac{1}{R_1 R_2} \right)$$
 Mirror losses expressed as "loss per unit length"

$$g_{th} = \alpha_r \equiv \alpha_m + \alpha_S$$
 all cavity losses:  $\alpha_r$ 

• Threshold current density:  $g_{th} = \alpha_r = \alpha \left( \frac{J_{th}}{J_T} - 1 \right) \Rightarrow J_{th} = \frac{\alpha_r + \alpha}{\alpha} J_T$ 

material absorption

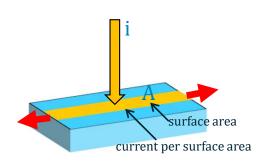


#### Laser diode characteristics (1)

Photon flux in the laser  $\Phi$  with the current  $i = J \cdot A$ 

$$\Phi = \begin{cases} \eta_{in} \frac{i - i_{th}}{e} & i > i_{th} \\ 0 & i < i_{th} \end{cases} \quad \begin{array}{l} i_{th} = J_{th} \cdot A & \text{Compare with (13.1)} \\ \text{Compare with (13.1)} \\ \text{Internal quantum efficiency } \eta_{in} \end{cases}$$

$$i_{th} = J_{th} \cdot A$$
 Compare with (13.36)



Internal laser power

$$P = \eta_{in}(i-i_{th})rac{h v}{e}$$
 collecting light through both mirrors

Extraction efficiency

$$\eta_e = \frac{\alpha_m}{\alpha_m + \alpha_S} = \frac{\alpha_m}{\alpha_r} = \frac{1}{\alpha_r 2L} ln \left(\frac{1}{R_1 R_2}\right)$$

**Emitted** power

$$P_0 = \eta_d (i - i_{th}) \frac{h\nu}{e}$$

with  $\eta_d = \eta_{in}\eta_e$  the external differential quantum efficiency

### Laser diode characteristics (2)

Differential efficiency

$$\Re_d = \frac{dP_0}{di} = \eta_d \frac{h\nu}{e}$$

Global efficiency

$$\eta = \frac{P_0}{P_{el}} = \eta_d \left( 1 - \frac{i_{th}}{i} \right) \frac{h\nu}{eV}$$

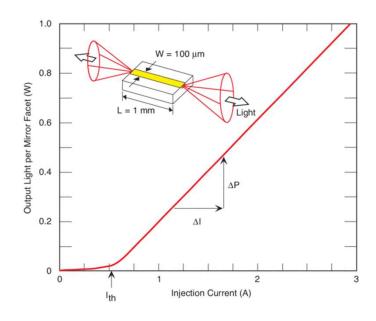
with

$$P_{el} = i \cdot V$$

(optical output power ratio to electrical input power i·V)

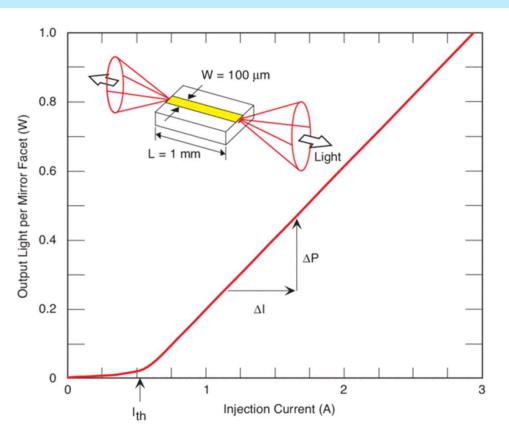
Example graph optical output power vs electrical input power.

https://www.newport.com/t/laser-diode-technology





#### Question



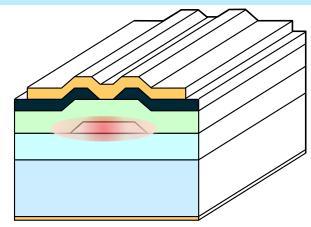
https://www.newport.com/t/laser-diode-technology

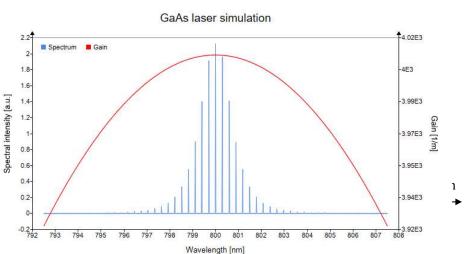
- Assume the data presented are from a GaAs laser
  - Calculate the transparency current and current density for this laser.
  - Comment on the difference between the transparency and threshold current. Discuss possible causes for the difference?



#### Modes in the DH-laser

- Cavity formed by waveguide
  - → no Gaussian beams
  - → output beam quality depends on waveguide
- Lateral-transversal modes:Often possible to isolate one mode
  - dimensions → V parameter
  - Index contrast
- Longitudinal modes:
  - short cavity → large mode spacing
  - Band structure → broad gain spectrum
  - → Still multiple modes
  - → use filters / dispersive elements

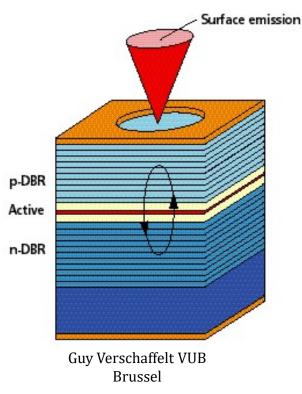






#### **VCSEL**

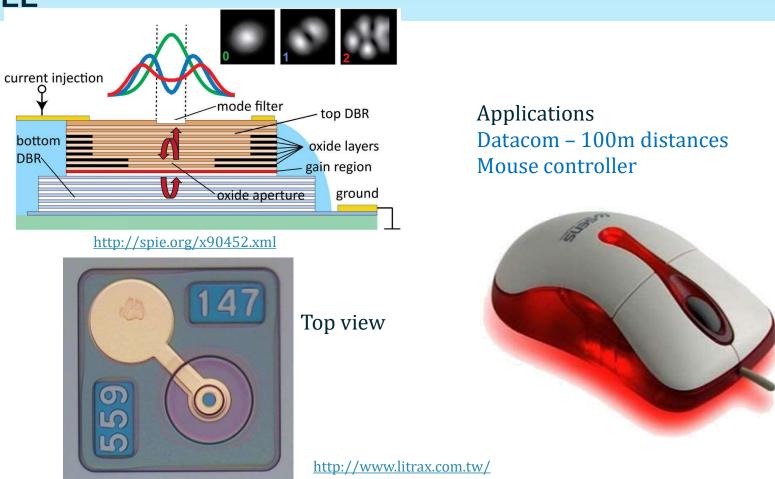
- Vertical cavity surface emitting laser
  - Make the cavity very short-> mode spacing larger than gain bandwidth->only one longitudinal mode is supported.



- Advantages:
  - compact very short cavity
  - low threshold
  - wafer testable
  - cheaper
  - dense 2D arrays
  - circular light beam fibre coupling
  - single frequency low noise
- Difficulties:
  - high reflectivity mirrors
  - series resistance in mirror
  - current flow guiding









#### Semiconductor lasers vs. other

#### Semiconductor

- Band structure
- Semiconductor cavity with flat mirrors
- Very small dimensions (<mm)</li>
- Diffraction limited beam, but large divergence angle (good spatial coherence)
- Multiple longitudinal modes (bad temporal coherence)
- Energy consumption to make laser transparent

#### Gas/Solid-state lasers

- Discrete levels
- Separate spherical mirrors
- Bulky (cm-m)
- Smaller diffraction angle
- Can easily be made single mode
- High power applications (kW)
- High peak power
- Smallest linewidths

#### **Photonics**

## Advantages of laser diodes

- Compact (can be packaged as electronic component)
- Simple electrical pumping: low currents / voltages
- Large modulation bandwidth (GHz) (short photon/gain lifetime)
- High efficiency (10%-50%)
- Large gamma of materials: different wavelengths
- Tunable



### **VCSEL**: problem

#### VCSEL:

Vertical Cavity Surface Emitting Laser

- Semiconductor laser  $l_0=850$ nm
- Gain area: Quantum Wells (L=2l/n)
- Mirror: Distr. Bragg Reflector  $(R_{1/2}=0.999)$
- injection efficiency  $\eta_{in}$ =0.8
- scattering  $\alpha_s$  in MQW area

#### Wanted:

- $\mathbf{g}_0$  for threshold neglecting scattering loss
- maximum scattering loss  $\alpha_s$  in the gain area for an output power of 1mW when pumping 4mA above threshold
- what is  $g_0$  and max  $\alpha_s$  if the front mirror is only reflecting  $R_1$ =0.99

